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		Application Number	New Application 10/582,293		
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		First Named Inventor	Matthew GAVED et al		
		Art Unit	2882		
		Examiner Name	Allen C. Ho		
		Attorney Docket Number	025538-00085		
Sheet	1	of	2		

### NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
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Examiner Signature	/Allen C. Ho/	Date Considered	05/25/2009
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